

Form PTO-1449

LIST OF PATENTS AND PUBLICATIONS FOR INFORMATION DISCLOSURE STATEMENT
(Use Several Sheets if Necessary)

APPLICANT: Philippe Lance et al.

ATTY. DOCKET #: SC0862ET

FILING DATE: Concurrently Herewith

APPL. #: Unknown

GROUP: Unknown

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E. J. J. J. J.
1-9-02

10578 U.S. PTO
09/934159

08/21/01

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	ISSUE DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
St	AA	5,829,879	11/3/98	Sanchez et al.	374	178	12/23/96
St	AB	5,201,841	4/13/93	Lebeau et al.	364	5	2/20/92
St	AC	5,237,481	8/17/93	Soo et al.	361	103	5/29/91
St	AD	3,868,508	2/25/75	Lloyd	250	330	10/30/73
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						

FOREIGN PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	PUBLICATION DATE (#43)	COUNTRY	CLASS	SUBCLASS
St	AL	WO 98/34101	8/6/98	PCT	G01N	25/72
St	AM	WO 00/40985	7/13/00	PCT	G01R	31/309
	AN					
	AO					
	AP					

OTHER INFORMATION (Including Author, Title, Date, Pertinent Pages, Etc.)

St	AR	EP 00402329 European Search Report, 3 pgs.	3/22/01
St	AS	Kallis, "Nondestructive Infrared Inspection of Hybrid Microcircuit Substrate-to-Packge Thermal Adhesive Bonds," IEEE Transactions on Components, Hybrids, and Manufacturing Technology, Vol. CHMT-4, No. 3, September 1981, 4 pp.	
	AT		
	AU		
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	AZ		

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OTHER PRIOR ART - NON PATENT LITERATURE DOCUMENTS			
Examiner Initials*	Cite No. 1	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T ²

Examiner Signature	Donald M. Lai	Date Considered	1/10/03
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¹ Unique citation designation number. ² See Kinds of U.S. Patent Documents. ³ Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). ⁴ For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. ⁵ Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST. 16 if possible. ⁶ Applicant is to place a check mark here if English Language Translation is attached.